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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
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EXAMINER

AGGARWAL, YOGESH K

ART UNIT	PAPER NUMBER
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2615

DATE MAILED: 06/09/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

09/537,669

Applicant(s)

YAMAMOTO, TAKESHI

Examiner

Yogesh K Aggarwal

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 26 March 2004.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-8 and 10-16 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-8 and 10-16 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 29 March 2000 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
- Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☒ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☒ All b) ☐ Some * c) ☐ None of:
1. ☒ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date _____.
- 4) ☐ Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____.
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____.

Response to Arguments

1. Applicant's arguments with respect to claim 1-8, 10-16 have been considered but are moot in view of the new ground(s) of rejection.
2. The cancellation of claim 9 is acknowledged.

Claim Rejections - 35 USC § 103

3. The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.
4. Claims 1, 2, 4, 7, 8, 10, 12, 13, 16 are rejected under 35 U.S.C. 103(a) as being unpatentable over Katoh et al. (US Patent # 5,796,430) in view of Pape et al. (US Patent # 5,047,863).

[Claim 1]

Katoh teaches an image processing apparatus for processing image data supplied from an image sensor (figure 1), comprising

A delay circuit (figure 7: 702) for receiving image data sequentially supplied from the image sensor, delaying the received image data by a time required for defect correction process, and supplying the delayed image data (col. 5 lines 39-52, figures 7, 8A-8D).

a counter (figure 5: 501, 502) for counting the number of pixels of image data sequentially transferred from the image sensor (col. 4 lines 37-53).

a defect correction circuit (figure 1: 107) for forming corrected image data for each pixel based on image data of pixels adjacent to a pixel of interest (col. 5 lines 24-29, figure 6)[The Examiner notes that the defect correction circuit 107 disclosed by Katoh in col. 5 lines 24-29, figure 6 for forming corrected image data checks the threshold level of each pixel (col. 4 lines

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31-36) and the pixel for which the signal level exceeds the threshold level is stored in the memory. Therefore in response to applicant's argument that the references fail to show certain features of applicant's invention, it is noted that the features upon which applicant relies (i.e. defect correction circuit 2 calculates correction data for all the pixels irrespective of whether or not there is a defective pixel, See Page 8 lines 14-16 of the Specification) are not recited in the rejected claim(s). Although the claims are interpreted in light of the specification, limitations from the specification are not read into the claims. See *In re Van Geuns*, 988 F.2d 1181, 26 USPQ2d 1057 (Fed. Cir. 1993)].

Katoh further teaches a control means (figure 1: 103 for generating CK1 shown in figure 7) for writing the image data supplied from said defect correction circuit in the first field of said memory at a storage location corresponding to the defect pixel, if a count of said counter becomes coincident with a number corresponding to the position data of the defective pixel in the second field of a memory (col. 5 lines 14-18). Figures 7 and 8A-8D disclose that the image data supplied from the delay circuit which is not defective (e.g. A.sub.11) must be stored in the same memory 110, if the count is not coincident with the number corresponding to the position data of the defective pixel. Katoh does not explicitly teach a memory wherein a memory having a first field for storing image data of one frame and a second field for storing position data of a defective pixel of the image sensor. However Pape et al. teaches that this limitation is well known and used in the art (col. 3 lines 43-49, figure 1: 16). Therefore taking the combined teachings of Katoh and Pape, it would have been obvious to one skilled in the art at the time of the invention to have been motivated to incorporate a memory wherein a memory having a first field for storing image data of one frame and a second field for storing position data of a

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defective pixel of the image sensor into the image processing circuit of Katoh as taught by Pape.

The benefit of doing so would be that same memory can be used for storing image data as well as position information of defective pixels leading to a cost saving in terms of die area.

[Claim 2]

Pape teaches a storage location in said memory (figure 1: 16) is identified by a row address and a column address, the first field stores the image data of each line at a corresponding row address, and the second field stores the position data of the defective pixel at the same row address” reads on Pape (col. 4 lines 30-46). [Lines 30-38 show that if the dark pixel does not exceed the threshold i.e. if it is a good pixel then it is stored in the frame buffer 16 by the write pulse. Lines 39-46 show that if the dark pixel data exceeds a threshold i.e. for a defective pixel a prior pixel is substituted from an output register 34 (part of the memory 16) into the frame buffer 16 by the read pulse (control means) at the same (x, y) location of the good pixel].

[Claim 4]

Katoh teaches, “.... wherein said defect correction circuit calculates an average of image data of pixels adjacent to a subject pixel” (col. 6 lines 18-22, figure 11E).

[Claim 7]

Katoh teaches an image pickup apparatus including a display device for displaying an image signal processed by the image processing apparatus according to claim 1 (col. 5 lines 7-14).

[Claim 8]

An image pickup apparatus according to claim 7, wherein the display device is a liquid crystal display. Official Notice is taken of the fact that both the concept and advantages of providing a

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LCD as a display device are well known and expected in the art. It would have been obvious to have a LCD as a display device because it has a compact size and good image quality.

[Claims 10, 12, 13]

These are method claims corresponding to the apparatus claims 1 and 4 respectively. Therefore it has been analyzed and rejected based on the claim 1 and 4.

[Claim 16]

Grounds for rejecting claim 13 apply for claim 16 completely. (Dividing a sum of pixel data of two pixels adjacent to a subject pixel and cutting a lowest one bit is the same as dividing the sum of pixel adjacent to each other by two i.e. taking the average of two which is the same as Claim 13).

5. Claims 3, 5, 6 and 11 are rejected under 35 U.S.C. 103(a) as being unpatentable over Katoh et al. (US Patent # 5,796,430) in view of Pape et al. (US Patent # 5,047,863) and in further view of Rambaldi et al. (US Patent # 6618084).

[Claim 3]

Katoh in view of Pape fails to teach "An image processing apparatus according to claim 1, wherein the second field of said memory stores information representative of a single defective pixel or the number of consecutive defective pixels and information representative of a position of the defective pixel in each line". However the above limitations are well known in the art as evidenced by Rambaldi (col. 3 lines 35-38, 49-50).

Therefore taking the combined teachings of Katoh, Pape and Rambaldi, it would have been obvious to one skilled in the art to incorporate second field of said memory storing information representative of a single defective pixel or the number of consecutive defective

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pixels and information representative of a position of the defective pixel in each line. Doing so would recall the faulty pixels automatically prior to image generation as evidenced by Rambaldi (col. 3 lines 35-38).

[Claim 5]

Katoh in view of Pape fail to teach “.... an external memory, which store position data of defective pixel of the image sensor”. However the above limitations are well known in the art as evidenced by Rambaldi (Col. 5 lines 33-36, figure 1)[The reference teaches that it may be desirable to include memory 26 on the chip but it may be external too].

Therefore taking the combined teachings of Pape and Rambaldi, it would have been obvious to one skilled in the art to incorporate an external memory, which store position data of defective pixel of the image sensor. Doing so would provide a memory as small as possible yet large enough to store all necessary information for correction/masking for each faulty pixel as evidenced by Rambaldi (col. 5 lines 34-36).

[Claim 6]

Pape fails to teach “.... wherein said memory is a dynamic random access memory”. However the above limitations are well known in the art as evidenced by Rambaldi (col. 5 line 48).

Therefore taking the combined teachings of Pape and Rambaldi as a whole, it would have been obvious to one skilled in the art to incorporate a memory, which is a dynamic random access memory. Doing so would provide a memory, which can be easily available between the size of 10 kilobits and 1 Megabit as evidenced by Rambaldi (col. 5 lines 44-45).

[Claim 11]

Claim 11 is a method claim corresponding to the apparatus claims 2 and 3. Therefore it has been analyzed and rejected based on the claims 2 and 3.

6. Claims 14 and 15 are rejected under 35 U.S.C. 103(a) as being unpatentable over Katoh et al. (US Patent # 5,796,430) in view of Pape et al. (US Patent # 5,047,863) as applied to claim 10 above and in further view of Tabei (US Patent # 5805216).

[Claim 14]

Katoh in view of Pape fail to teach "... wherein said step calculates an average of image data of pixels adjacent to a subject pixel in a column direction ". However the above limitations are well known in the art as evidenced by Tabei (col. 2 line 1-2 figure 3D). Therefore taking the combined teachings of Katoh, Pape and Tabei, it would have been obvious to one skilled in the art to calculate an average of image data of pixels adjacent to a subject pixel in a column direction. Doing so would provide a boundary between light and dark portions the place X in which a defective pixel is present is conspicuous as evidenced by Tabei (col. 1 lines 17-20).

[Claim 15]

Katoh in view of Pape fail to teach "... wherein said step (d) performs a weighing process in accordance with distances between pixels adjacent to a subject pixel and the subject pixel". However the above limitations are well known in the art as evidenced by Tabei (col. 6 lines 46-49 figure 12A to 12L). Therefore taking the combined teachings of Pape and Tabei, it would have been obvious to one skilled in the art to perform a weighing process in accordance with distances between pixels adjacent to a subject pixel and the subject pixel. Doing so would provide interpolation output interpolated by 12 kinds of interpolation methods as evidenced by Tabei (col. 6 lines 39-40).

Conclusion

7. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

8. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Yogesh K Aggarwal whose telephone number is (703) 305-0346. The examiner can normally be reached on M-F 9:00AM-5:30PM.

9. If attempts to reach the examiner by telephone are unsuccessful, the examiner's Primary Examiner, Ngoc Yen Vu can be reached on (703) 305-4946. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

YKA

June 2, 2004



NGOC-YEN VU
PRIMARY EXAMINER